CLF1G0060-10; CLF1G0060S-10

Broadband RF power GaN HEMT Rev. 2 — 29 January 2013

Objective data sheet

Product profile 1.

1.1 General description

The CLF1G0060-10 and CLF1G0060S-10 are 10 W general purpose broadband GaN HEMTs usable from DC to 6.0 GHz.

CW and pulsed RF application information

Typical RF performance at T_{case} = 25 °C; I_{Dq} = 40 mA; V_{DS} = 50 V in a class-AB broadband demo

Test signal	f	PL	G _p	η _D
	(MHz)	(W)	(dB)	(%)
1-Tone CW	200	10	17.7	42.6
	500	10	16.7	46.6
	1000	10	15	38.7
	1500	10	14.3	32.6
	2000	10	14.2	32.6
1-Tone pulsed [1]	200	10	18.8	44
	500	10	17.8	48.2
	1000	10	16.8	39
	1500	10	16.7	33.9
	2000	10	17	33.2

^[1] Pulsed RF; t_p = 15 μ s; δ = 10 %.

2-Tone CW application information

Typical 2-Tone performance at T_{case} = 25 °C; I_{Dq} = 40 mA; V_{DS} = 50 V in a class-AB broadband demo board.

Test signal	f	P _{L(PEP)}	IMD3
	(MHz)	(W)	(dBc)
2-Tone CW [1]	500	5	-47.4
	1000	5	-48.7
	1500	5	-44.7
	2000	5	-39.2
	2500	5	-40.4

^{[1] 2-}Tone CW; $\Delta f = 1$ MHz.



1.2 Features and benefits

- Frequency of operation is from DC to 6.0 GHz
- 10 W general purpose broadband RF Power GaN HEMT
- Excellent ruggedness (VSWR = 10 : 1)
- High voltage operation (50 V)
- Thermally enhanced package

1.3 Applications

- Commercial wireless infrastructure (cellular, WiMAX)
- Radar
- Broadband general purpose amplifier
- Public mobile radios

- Industrial, scientific, medical
- Jammers
- EMC testing
- Defense application

2. Pinning information

Table 3. Pinning

Pin	Description		Simplified outline	Graphic symbol
CLF1G00	60-10 (SOT1227A)			
1	drain		0	_
2	gate			اً
3	source	[1]		2 - 3
01 54 000	COC 40 (OOT4007D)			aaa-003693
CLF1G00	60S-10 (SOT1227B)			
1	drain		_	1
2	gate		1	ப்
3	source	[1]	2	2 → 3 3 aaa-003693

^[1] Connected to flange.

3. Ordering information

Table 4. Ordering information

Type number	Package	Package				
	Name	Description	Version			
CLF1G0060-10	-	flanged ceramic package; 2 mounting holes; 2 leads	SOT1227A			
CLF1G0060S-10	-	earless flanged ceramic package; 2 leads	SOT1227B			

4. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage		-	150	V
V_{GS}	gate-source voltage		-8	+3	V
I_{GF}	forward gate current	external $R_G = 5 \Omega$	-	3.7	mA
T _{stg}	storage temperature		-65	+150	°C
T _i	junction temperature	measured via IR scan	-	250	°C

5. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j\text{-}c)}$	thermal resistance from junction to case	$T_j = 200 ^{\circ}C$	[1] <tbd></tbd>	K/W

^[1] T_i is measured via IR scan with case temperature of 85 °C and power dissipation of <tbd> W.

6. Characteristics

Table 7. DC Characteristics

 T_{case} = 25 °C; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = -7 \text{ V};$ $I_{DS} = 2.4 \text{ mA}$	150	-	-	V
V _{GS(th)}	gate-source threshold voltage	$V_{DS} = 0.1 \text{ V};$ $I_{DS} = 2.4 \text{ mA}$	-2.4	-2	-1.6	V
I_{DSX}	drain cut-off current	$V_{DS} = 10 \text{ V}; V_{GS} = 3 \text{ V}$	-	1.7	-	Α
9fs	forward transconductance	$V_{DS} = 10 \text{ V}; V_{GS} = 0 \text{ V}$	-	0.38	-	S

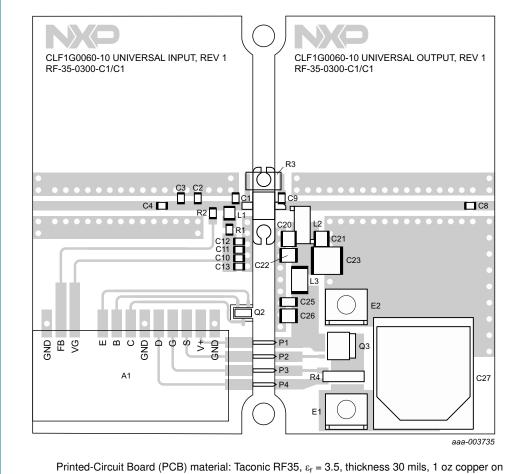
Table 8. RF Characteristics

Test signal: pulsed RF; t_p = 100 μ s; δ = 10 %; RF performance at V_{DS} = 50 V; I_{Dq} = 50 mA; T_{case} = 25 °C; unless otherwise specified in a class-AB production circuit.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
f	frequency		3	-	3.5	GHz
η_{D}	drain efficiency	$P_L = 10 \text{ W}$	-	49.5	-	%
Gp	power gain	$P_L = 10 \text{ W}$	-	14.5	-	dB
RLin	input return loss	$P_L = 10 \text{ W}$	-	-8.5	-	dB
P _{droop(pulse)}	pulse droop power	$P_L = 10 \text{ W}$	-	0.04	-	dB
t _r	rise time	$P_L = 10 \text{ W}$	-	5	-	ns
t _f	fall time	P _L = 10 W	-	5	-	ns

7. Application information

7.1 Demo circuit



Printed-Circuit Board (PCB) material: Taconic RF35, ε_r = 3.5, thickness 30 mils, 1 oz copper or each side.

See Table 9 for list of components.

Fig 1. The broadband amplifier (500 MHz to 2500 MHz) demo circuit outline

Table 9. List of components See Figure 1.

Component	Description	Value	Remarks
A1	GaN bias module v2	-	NXP
C1	multilayer ceramic chip capacitor	3.9 pF	ATC 600F
C2	multilayer ceramic chip capacitor	3.0 pF	ATC 600F
C3	multilayer ceramic chip capacitor	1.2 pF	ATC 600F
C4, C8	multilayer ceramic chip capacitor	33 pF	ATC 600F
C9	multilayer ceramic chip capacitor	10 pF	ATC 600F
C10	electrolytic capacitor	10 nF, 50 V	SMD 0805
C11	electrolytic capacitor	22 nF, 100 V	SMD 0805
C12	electrolytic capacitor	1 nF, 100 V	SMD 0805

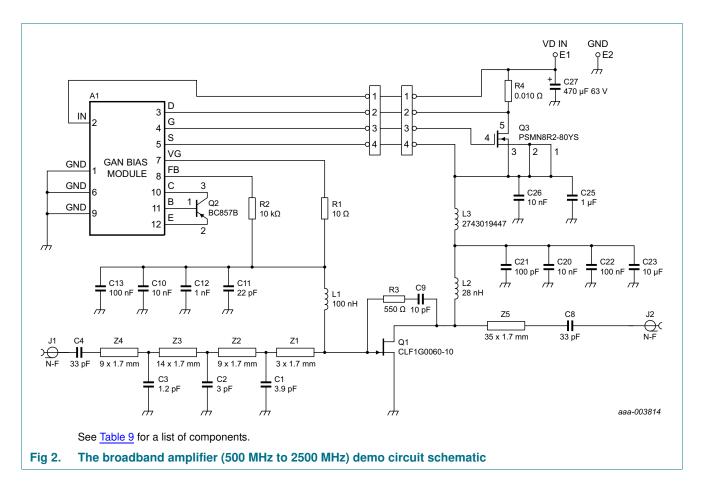
CLF1G0060-10_1G0060S-10

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Table 9.List of components ... continuedSee Figure 1.

Component	Description	Value	Remarks
C13	electrolytic capacitor	100 nF, 50 V	SMD 0805
C20	multilayer ceramic chip capacitor	1 nF	ATC 700B
C21	multilayer ceramic chip capacitor	100 pF	ATC 700B
C22, C26	electrolytic capacitor	10 nF, 200 V	SMD 1210
C23	electrolytic capacitor	10 μF, 100 V	SMD 2220
C25	electrolytic capacitor	1 μF, 100 V	SMD 1206
C27	electrolytic capacitor	470 μF, 63 V	Panasonic EEE-TK1J471AM
E1, E2	drain voltage connection	-	
J1	RF in connector	-	
J2	RF out connector	-	
L1	inductor	100 nH	Coilcraft 0805CS-101XJL
L2	inductor	28 nH	Coilcraft B08TJL
L3	ferrite bead	5 A	Fair-Rite 2743019447
P1, P2, P3, P4	1 row, 4-way vertical DC connector header	-	
Q1	transistor	-	CLF1G0060-10
Q2	transistor	-	NXP BC857B
Q3	transistor	-	NXP PSMN8R2-80YS
R1	resistor	10.0 Ω	Generic
R2	resistor	10.0 kΩ	Generic
R3	resistor	550 Ω	Generic
R4	resistor	0.01 Ω	Susumu RL7520WT-R010-F



7.2 Application test results

Table 10. CW and pulsed RF application information

Typical RF performance at T_{case} = 25 °C; I_{Dq} = 40 mA; V_{DS} = 50 V in a class-AB broadband demo board.

Test signal	f	PL	Gp	η _D
	(MHz)	(W)	(dB)	(%)
1-Tone CW	200	10	17.7	42.6
	500	10	16.7	46.6
	1000	10	15	38.7
	1500	10	14.3	32.6
	2000	10	14.2	32.6
1-Tone pulsed [1]	200	10	18.8	44
	500	10	17.8	48.2
	1000	10	16.8	39
	1500	10	16.7	33.9
	2000	10	17	33.2

^[1] Pulsed RF; t_p = 15 $\mu s;$ δ = 10 %.

Table 11. 2-Tone CW application information

Typical 2-Tone performance at T_{case} = 25 °C; I_{Dq} = 40 mA; V_{DS} = 50 V in a class-AB broadband demo board.

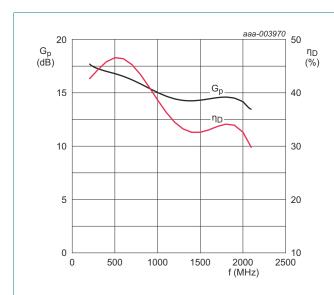
Test signal	f	$P_{L(PEP)}$	IMD3
	(MHz)	(W)	(dBc)
2-Tone CW [1]	500	5	-47.4
	1000	5	-48.7
	1500	5	-44.7
	2000	5	-39.2
	2500	5	-40.4

^{[1] 2-}Tone CW; $\Delta f = 1$ MHz.

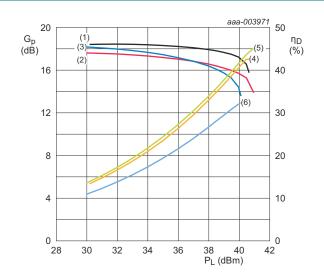
7.3 Graphical data

The following figures are measured in a broadband amplifier demo board from 500 MHz to 2500 MHz.

7.3.1 1-Tone CW RF performance



 $V_{DS} = 50 \text{ V}; I_{Dq} = 40 \text{ mA}; P_L = 10 \text{ W}.$



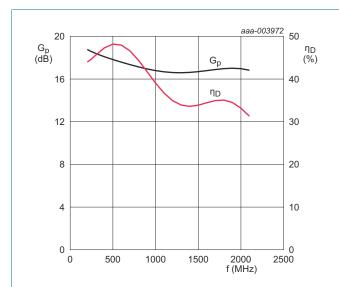
 $V_{DS} = 50 \text{ V}; I_{Dq} = 40 \text{ mA}.$

- (1) G_p at f = 200 MHz
- (2) G_p at f = 1000 MHz
- (3) G_D at f = 2000 MHz
- (4) η_D at f = 200 MHz
- (5) η_D at f = 1000 MHz
- (6) η_D at f = 2000 MHz

Fig 3. Power gain and drain efficiency as function of frequency; typical values

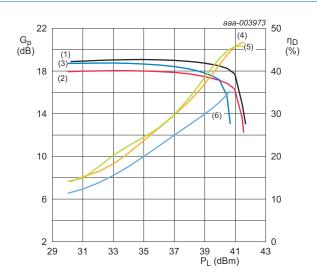
Fig 4. Power gain and drain efficiency as function of output power; typical values

7.3.2 1-Tone pulsed RF performance



 V_{DS} = 50 V; I_{Dq} = 40 mA; P_L = 10 W; t_p = 15 $\mu s;$ δ = 1 %.

Power gain and drain efficiency as function of Fig 5. frequency; typical values

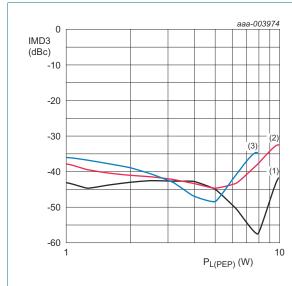


 V_{DS} = 50 V; I_{Dq} = 40 mA; t_p = 15 $\mu s; \, \delta$ = 1 %.

- (1) G_p at f = 200 MHz
- (2) G_p at f = 1000 MHz
- (3) G_p at f = 2000 MHz
- (4) η_D at f = 200 MHz
- η_D at f = 1000 MHz
- η_D at f = 2000 MHz

Fig 6. Power gain and drain efficiency gain as function of output power; typical values

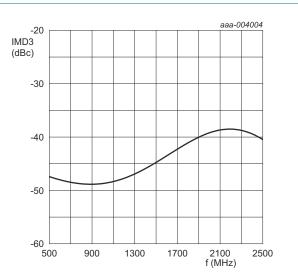
7.3.3 2-Tone CW performance



 V_{DS} = 50 V; I_{Dq} = 50 mA; Δf = 1 MHz.

- (1) f = 300 MHz
- (2) f = 1100 MHz
- (3) f = 2000 MHz

Fig 7. Third-order intermodulation distortion as a function of peak envelope power; typical values



 $V_{DS} = 50 \text{ V}; I_{Dq} = 150 \text{ mA}; P_{L(PEP)} = 10 \text{ W}.$

Fig 8. Third-order intermodulation distortion as a function of frequency; typical values

7.3.4 Bias module

The bias module information for the GaN HEMT amplifier is described in application note "AN11130".

8. Test information

8.1 Ruggedness in class-AB operation

The CLF1G0060-10 and CLF1G0060S-10 are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: $V_{DS} = 50 \text{ V}$; $P_L = 10 \text{ W}$ (pulsed RF), f = <tbd> MHz.

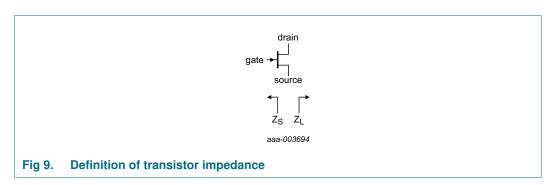
8.2 Load pull impedance information

The measured load pull impedances are shown below. Impedance reference plane defined at device leads. Measurements performed with NXP test fixtures. Test temperature set at 25 °C with a pulsed CW signal; t_p = 100 μs ; δ = 10 %; RF performance at V_{DS} = 50 V; I_{Dq} = 20 mA.

Table 12. Typical impedance

Typical values unless otherwise specified.

f	Z _S	Z _L (maximum P _{L(M)})	Z _L (maximum η _D)
MHz	Ω	Ω	Ω
2500	4.7 - 3.8j	23.1 + 22.6j	12 + 28.4j
2700	4.5 – 6.3j	19.5 + 22.2j	9.1 + 25.1j
3300	6.6 – 14j	14 + 13.5j	7.9 + 18.6j
3500	6.5 – 18j	12.7 + 14.7j	7.5 + 15.6j
3700	8.1 – 22j	12.7 + 14.7j	6.7 + 14.6j
4000	8.3 – 32j	9.5 + 13.8j	6.5 + 13.8j



 Z_S is the measured source pull impedance presented to the device. Z_L is the measured load pull impedance presented to the device.

8.3 Packaged S-parameter data

Table 13. S-parameter

Small signal; V_{DS} = 50 V; I_{Dq} = 20 mA; Z_S = Z_L = 50 Ω

	S ₁₁		S ₂₁	S ₂₁		S ₁₂		S ₂₂	
(MHz)	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)	
100	0.99129	-23.269	21.314	164.59	0.0071276	75.423	0.95962	-10.001	
200	0.96902	-44.968	19.981	150.22	0.013329	61.893	0.92382	-19.186	
300	0.94116	-64.133	18.221	137.49	0.018152	50.009	0.87835	-27.146	
400	0.91414	-80.511	16.383	126.5	0.021627	39.869	0.83352	-33.905	
500	0.89101	-94.309	14.666	117.04	0.024008	31.278	0.79464	-39.708	
600	0.87242	-105.92	13.145	108.84	0.025571	23.957	0.76322	-44.832	
700	0.85792	-115.75	11.832	101.62	0.026538	17.641	0.73885	-49.499	
300	0.84676	-124.16	10.706	95.167	0.027071	12.118	0.72048	-53.868	
900	0.83822	-131.44	9.7421	89.316	0.027281	7.2229	0.70698	-58.039	
1000	0.8317	-137.82	8.9136	83.937	0.027246	2.8351	0.69734	-62.075	
1100	0.82673	-143.48	8.1977	78.936	0.027018	-1.1346	0.69074	-66.012	
1200	0.82294	-148.57	7.5751	74.24	0.026636	-4.751	0.68654	-69.873	
1300	0.82008	-153.2	7.0302	69.796	0.026128	-8.0607	0.68423	-73.666	
1400	0.81793	-157.44	6.5504	65.559	0.025514	-11.096	0.6834	-77.399	
1500	0.81633	-161.37	6.1253	61.499	0.024809	-13.878	0.68374	-81.073	
1600	0.81517	-165.04	5.7467	57.588	0.024028	-16.42	0.68499	-84.69	
1700	0.81435	-168.5	5.4078	53.806	0.023179	-18.725	0.68697	-88.25	
1800	0.81379	-171.78	5.103	50.136	0.022272	-20.79	0.68951	-91.753	
1900	0.81344	-174.91	4.8277	46.564	0.021316	-22.605	0.69248	-95.199	
2000	0.81325	-177.92	4.5781	43.078	0.020316	-24.15	0.69577	-98.59	
2100	0.81317	179.17	4.351	39.668	0.019282	-25.396	0.6993	-101.92	
2200	0.81318	176.35	4.1437	36.326	0.018222	-26.304	0.70298	-105.21	
2300	0.81325	173.6	3.954	33.045	0.017143	-26.82	0.70677	-108.43	
2400	0.81336	170.91	3.7798	29.818	0.016058	-26.873	0.71061	-111.61	
2500	0.8135	168.27	3.6196	26.639	0.014978	-26.372	0.71447	-114.74	
2600	0.81364	165.66	3.4718	23.502	0.013923	-25.202	0.7183	-117.83	
2700	0.81378	163.09	3.3353	20.404	0.012912	-23.223	0.72209	-120.87	
2800	0.8139	160.54	3.2089	17.34	0.011978	-20.279	0.72581	-123.87	
2900	0.81401	158	3.0917	14.305	0.011158	-16.219	0.72943	-126.83	
3000	0.81409	155.48	2.9828	11.296	0.0105	-10.954	0.73296	-129.76	
3100	0.81414	152.96	2.8815	8.3092	0.010059	-4.5429	0.73637	-132.66	
3200	0.81416	150.44	2.7871	5.341	0.00989	2.7229	0.73966	-135.53	
3300	0.81415	147.91	2.6991	2.3882	0.010031	10.309	0.74282	-138.37	
3400	0.8141	145.38	2.6169	-0.5524	0.010495	17.578	0.74585	-141.19	
3500	0.81402	142.83	2.5399	-3.4839	0.011266	23.999	0.74874	-144	
3600	0.81392	140.27	2.4679	-6.4092	0.012313	29.286	0.75149	-146.78	
3700	0.81378	137.69	2.4004	-9.3313	0.013594	33.387	0.7541	-149.56	

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 Table 13.
 S-parameter ...continued

Small signal; \dot{V}_{DS} = 50 V; I_{Dq} = 20 mA; Z_S = Z_L = 50 Ω

f (MHz)	S ₁₁		S ₂₁		S ₁₂		S ₂₂	
	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)	Magnitude (ratio)	Angle (degree)
3800	0.81362	135.09	2.337	-12.253	0.015073	36.394	0.75657	-152.33
3900	0.81344	132.46	2.2775	-15.177	0.016718	38.458	0.75891	-155.09
4000	0.81325	129.8	2.2215	-18.106	0.018506	39.738	0.76111	-157.86
4100	0.81305	127.11	2.1687	-21.043	0.020419	40.375	0.76318	-160.63
4200	0.81286	124.39	2.119	-23.991	0.022446	40.485	0.76513	-163.4
4300	0.81267	121.64	2.072	-26.952	0.024575	40.163	0.76694	-166.19
4400	0.8125	118.84	2.0276	-29.928	0.026802	39.483	0.76865	-168.99
4500	0.81236	116.01	1.9856	-32.922	0.029121	38.504	0.77023	-171.81
4600	0.81226	113.13	1.9457	-35.937	0.031528	37.269	0.77171	-174.65
4700	0.81221	110.22	1.9078	-38.976	0.034021	35.816	0.77309	-177.52
4800	0.81222	107.25	1.8718	-42.04	0.036598	34.172	0.77438	179.58
4900	0.81231	104.25	1.8374	-45.132	0.039257	32.359	0.77558	176.64
5000	0.81249	101.19	1.8045	-48.254	0.041996	30.394	0.77669	173.66
5100	0.81278	98.091	1.7729	-51.409	0.044813	28.293	0.77774	170.63
5200	0.81319	94.941	1.7426	-54.599	0.047706	26.065	0.77873	167.55
5300	0.81374	91.743	1.7133	-57.826	0.050674	23.72	0.77966	164.42
5400	0.81444	88.496	1.685	-61.092	0.053712	21.266	0.78055	161.22
5500	0.81531	85.202	1.6575	-64.4	0.056818	18.706	0.7814	157.96
5600	0.81637	81.859	1.6307	-67.75	0.059987	16.048	0.78224	154.63
5700	0.81764	78.47	1.6044	-71.146	0.063214	13.293	0.78307	151.22
5800	0.81912	75.035	1.5786	-74.588	0.066493	10.446	0.78391	147.73
5900	0.82083	71.556	1.5531	-78.079	0.069817	7.508	0.78477	144.15
6000	0.82279	68.034	1.5277	-81.619	0.073177	4.4824	0.78566	140.48

9. Package outline

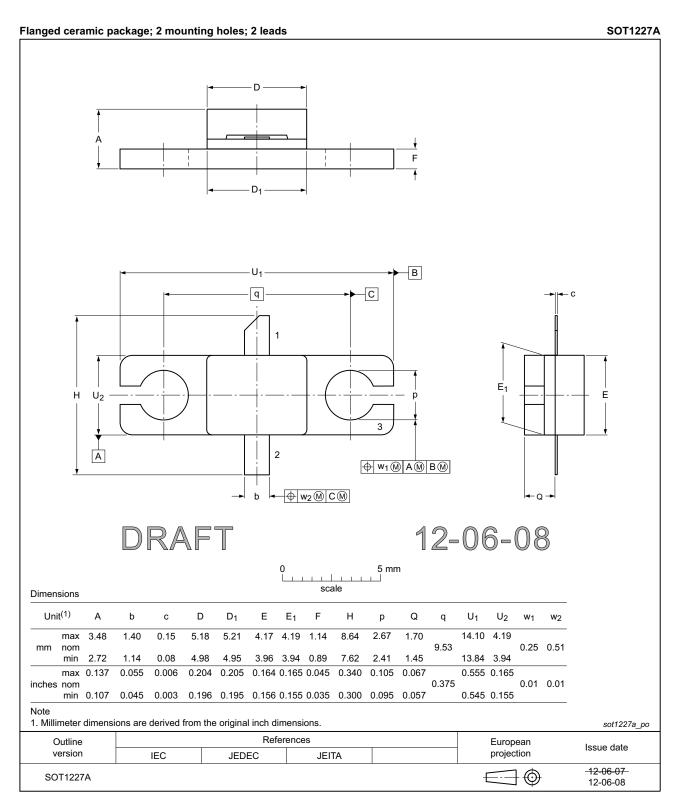


Fig 10. Package outline SOT1227A

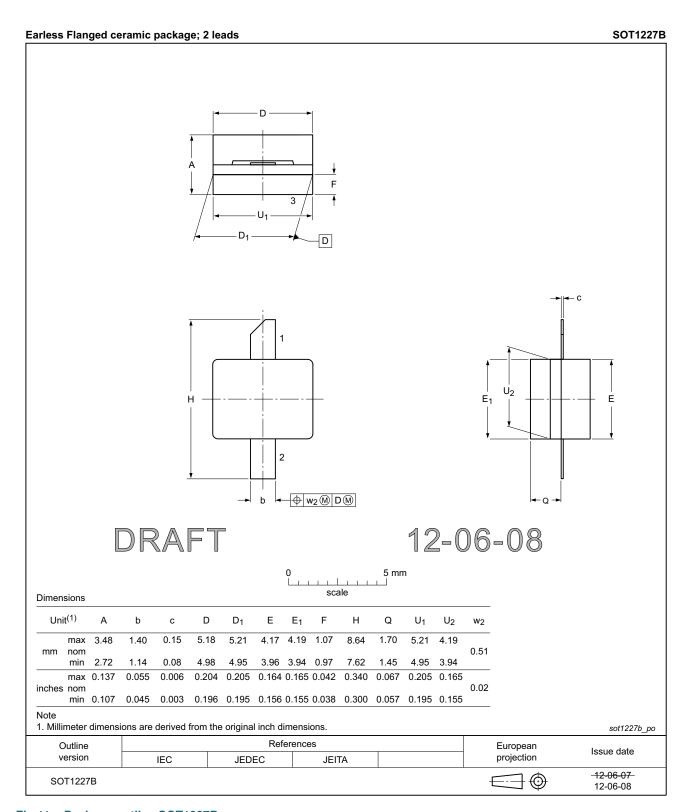


Fig 11. Package outline SOT1227B

10. Handling information

10.1 ESD Sensitivity

Table 14. ESD sensitivity

ESD model	Class
Human Body Model (HBM); According JEDEC standard JESD22-A114F	1B [1]

^[1] Classification 1B is granted to any part that passes after exposure to an ESD pulse of 500 V, but fails after exposure to an ESD pulse of 1000 V.

11. Abbreviations

Table 15. Abbreviations

Acronym	Description
CW	Continuous Wave
EMC	ElectroMagnetic Compatibility
ESD	ElectroStatic Discharge
GaN	Gallium Nitride
HEMT	High Electron Mobility Transistor
SMD	Surface-Mounted Device
VSWR	Voltage Standing-Wave Ratio
WiMAX	Worldwide Interoperability for Microwave Access

12. Revision history

Table 16. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
CLF1G0060-10_1G0060S-10 v.2	20130129	Objective data sheet	-	CLF1G0060-10_1G0060S-10 v.1
Modifications:	• Table 7 or	n page 3: table has bee	en updated.	
	• <u>Table 8 or</u>	n page 3: table has bee	en updated.	
	• Section 7	on page 4: layout has	been changed.	
	• Table 9 or	n page 4: row 1 has be	en changed.	
	• Section 8	on page 9: layout has	been changed.	
CLF1G0060-10_1G0060S-10 v.1	20121008	Objective data sheet	-	-

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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